Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,238	KAN, MAKIKO
Examiner	Art Unit

Sun J. Lin

2825

SEARCHED			
Class	Subclass	Date	Examiner
716	1	8/11/2005	JSL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	8/11/2005	JSL
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